

γ -ray beam diagnostic for the GF@CERN

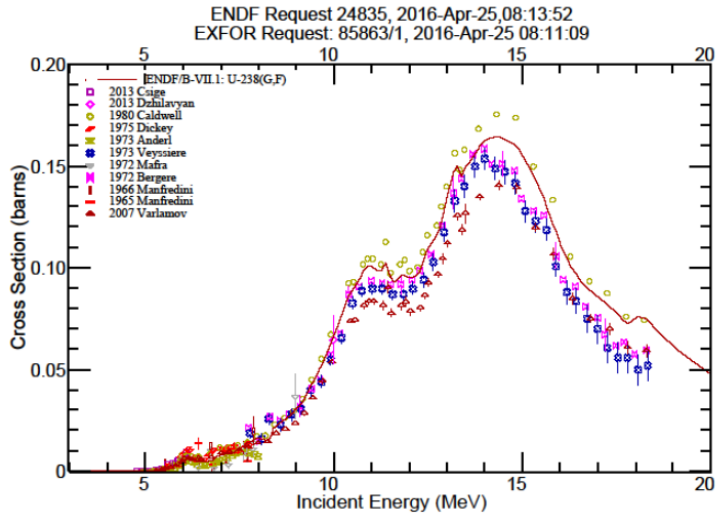
A. Musumarra and M.G. Pellegriti

Example of gamma (neutron) flux characterization

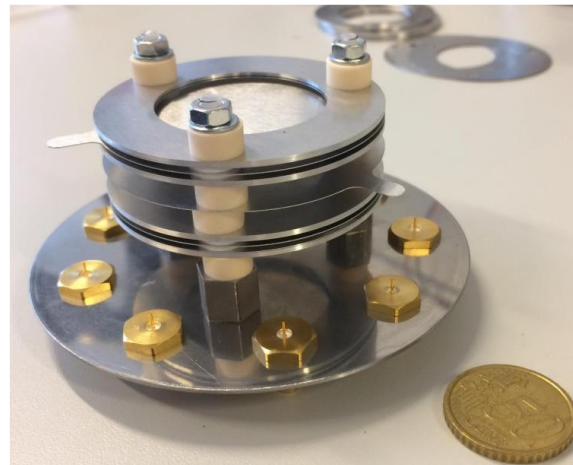
Gas detector (IC-Micromesh-PPAC)

PTB CEA-Saclay Orsay

PTB Fission Chamber and Micromegas

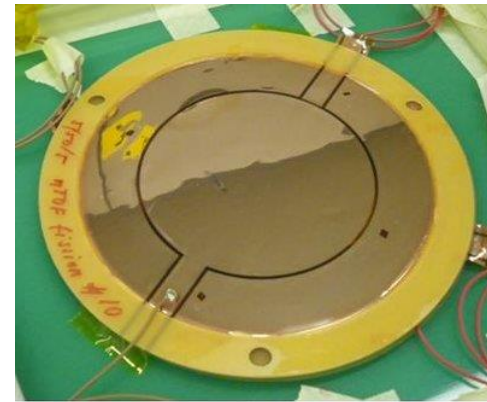


Photofission cross-section for U-238

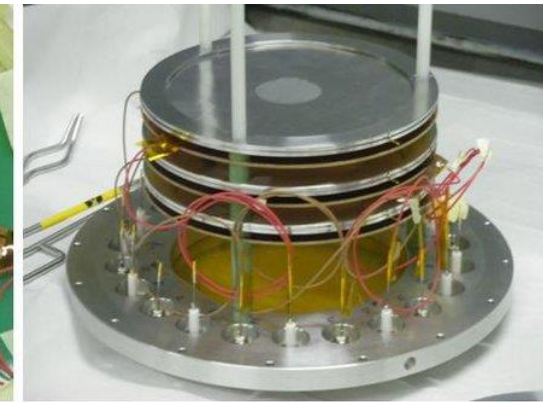


ELI-NP fission chamber

Reaction	Standard energy range
${}^6\text{Li}(n, t)$	0.0253 eV to 1 MeV
${}^{10}\text{B}(n, \alpha)$	0.0253 eV to 1 MeV
${}^{235}\text{U}(n, f)$	0.0253 eV and 0.15–200 MeV
${}^{197}\text{Au}(n, \gamma)$	0.0253 eV and 0.2–2.5 MeV



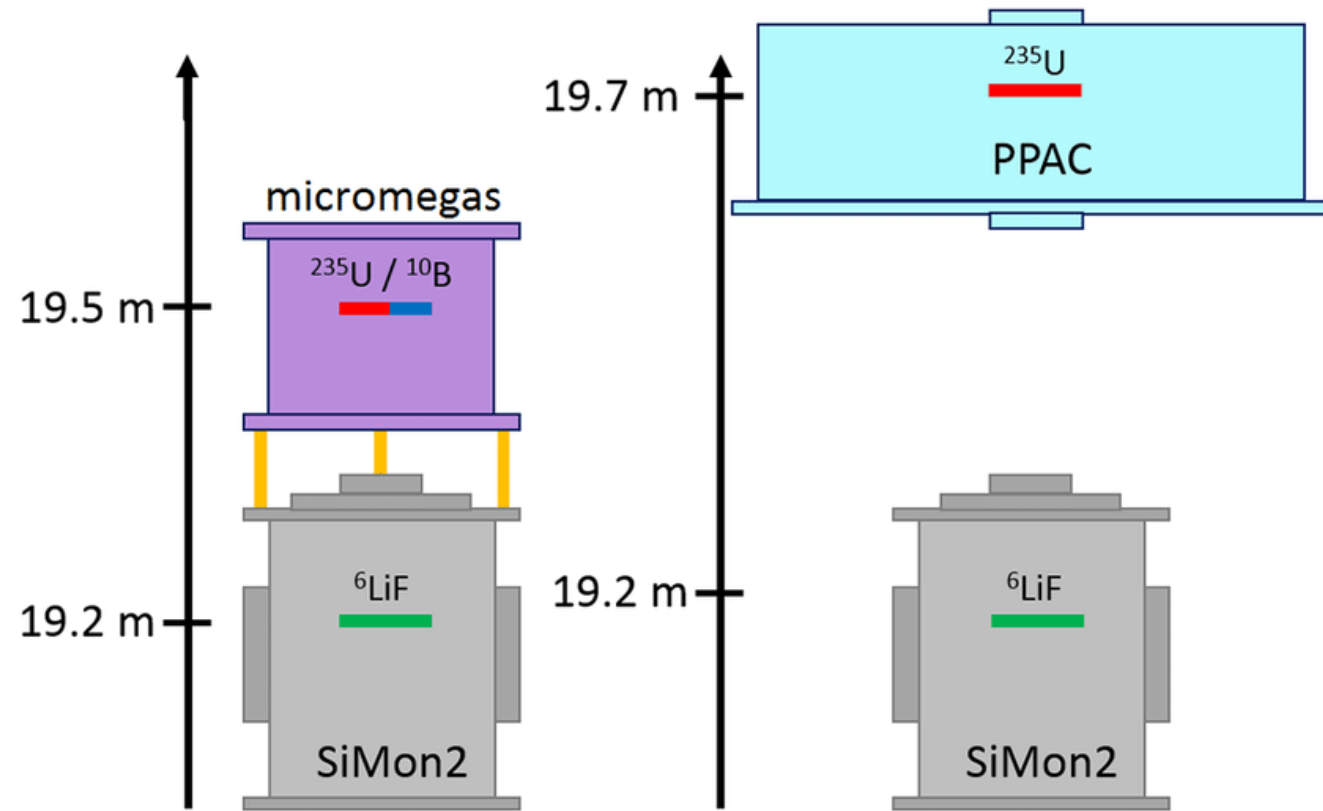
(a)



(b)

n-flux characterization routinely performed by PTB fission chamber, MGAS and SiMon detectors (**also stacked**)

Micromegas@n_TOF



The European Physical Journal A volume 49, Article number: 156 (2013)

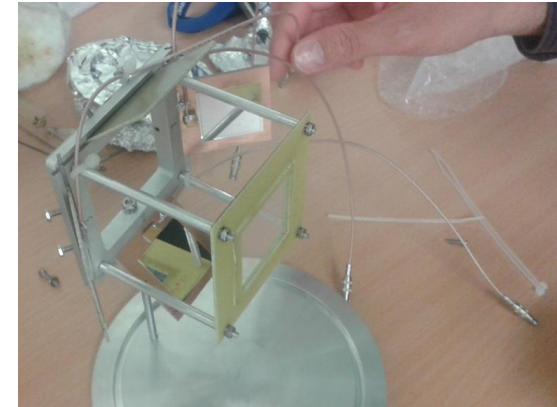
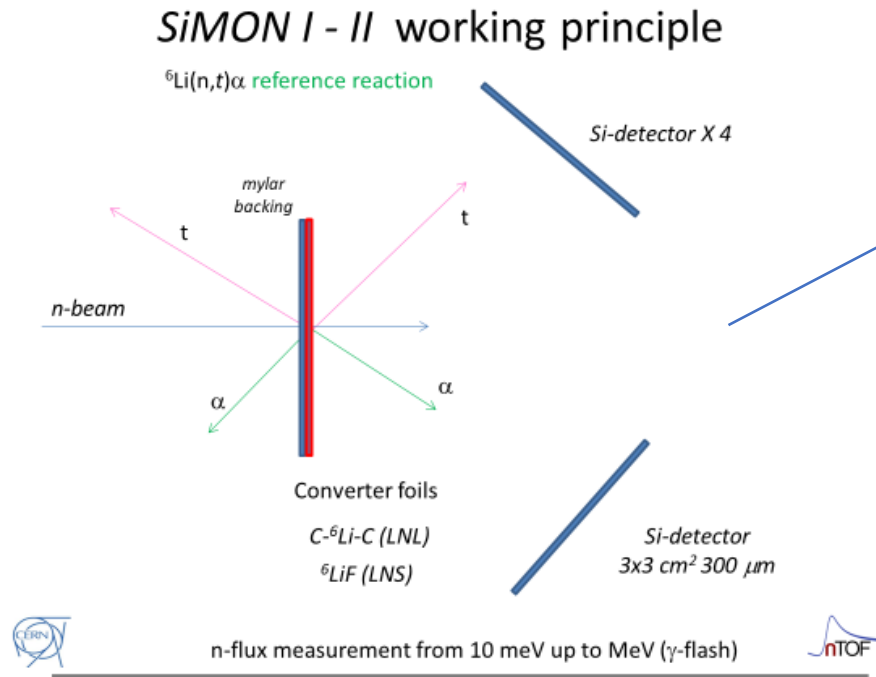
EAR2@ n_TOF



<https://cds.cern.ch/record/1746358>

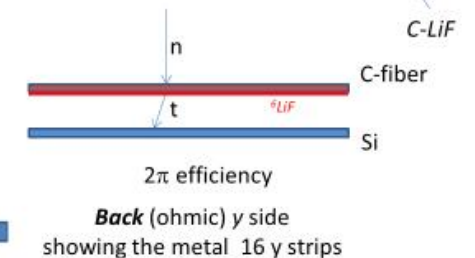
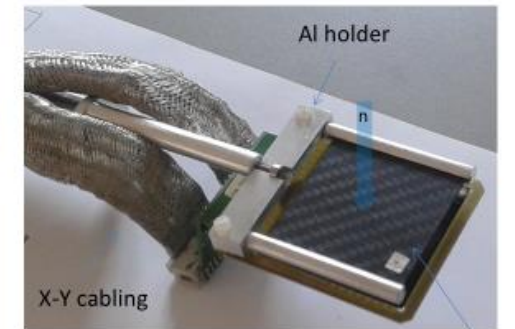
Some example of neutron flux characterization n_TOF@CERN (INFN)

Solid-state: Silicon detector (SiMON)



SiMON 2D

Front (junction) x side with Carbon fiber+ ${}^6\text{LiF}$



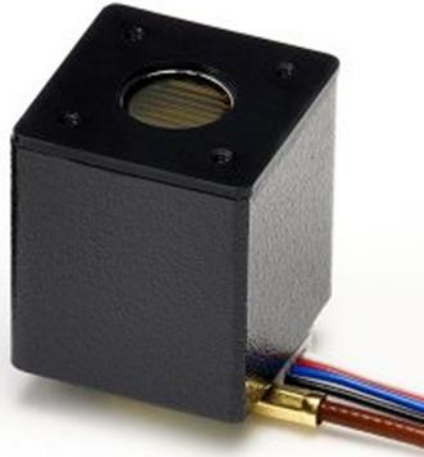
Fully Operational **in-air** and **in-vacuum**



A. Musumarra et al. Int.J.Mod.Phys.Conf.Ser. 44 (2016) 1660210

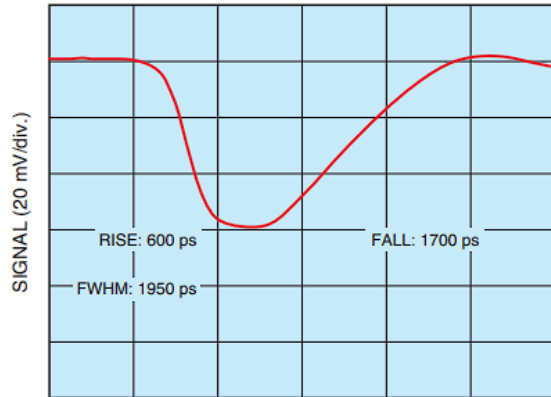
Same technique to be used for (γ,cp) reactions

Photomultiplier already at INFN-CT scintillator
will be delivered by SCIONIX on January 2024



H14601-200

■ H14600-100



TIME (1 ns/div.)

Parameter		H14600 / H14601 series				Unit	
Suffix		-100, -103	-200	-01, -04	-20	—	
Input voltage		+4.5 to +5.5				V	
Max. input voltage		5.5				V	
Max. input current *1		3.5				mA	
Max. average output signal current *2		100				μA	
Max. control voltage		+1.0 (Input impedance 1 MΩ)				V	
Recommended control voltage adjustment range		+0.5 to +1.0 (Input impedance 1 MΩ)				V	
Effective area		φ8				mm	
Peak sensitivity wavelength		400	400	400	630	nm	
Cathode	Luminous sensitivity	Min.	80	100	100	350	μA/lm
		Typ.	105	135	200	500	
	Blue sensitivity index (Blue filter)	Typ.	13.5	15.5	—	—	—
	Red/White ratio	Typ.	—	—	0.25	0.45	—
Radiant sensitivity *3		Typ.	110	130	77	78	mA/W
Anode	Luminous sensitivity *2	Min.	30	40	40	140	A/lm
		Typ.	105	135	200	500	
	Radiant sensitivity *2*3	Typ.	1.1 × 10 ⁵	1.3 × 10 ⁵	7.7 × 10 ⁴	7.8 × 10 ⁴	A/W
	Dark current *2*4	Typ.	0.5	0.5	1	10	nA
Max.		5	5	10	100		
Rise time *2		Typ.	0.6			ns	
Ripple noise *2*5 (peak to peak)		Max.	0.2			mV	
Settling time *6		Max.	10			s	
Operating ambient temperature *7		+5 to +50				°C	
Storage temperature *7		-20 to +50				°C	
Weight		32 (H14600 series), 40 (H14601 series)				g	

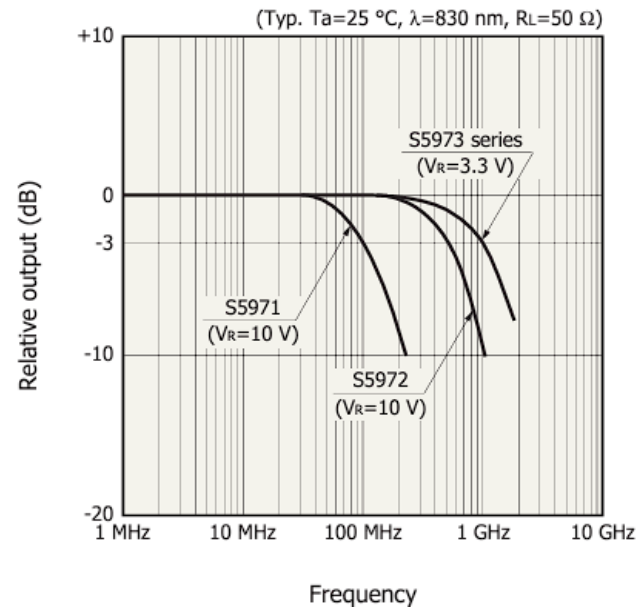
Second option: Si-junction (SiC/Diamond) for x-ray spectroscopy

Si PIN HAMAMTSU Photodiode 320-1000nm

Metal TO-18 available and tested with HG charge pre-amp

ϕ 0.4 mm

Frequency response



S5973 series



Contents lists available at [ScienceDirect](https://www.sciencedirect.com)

Nuclear Inst. and Methods in Physics Research, A

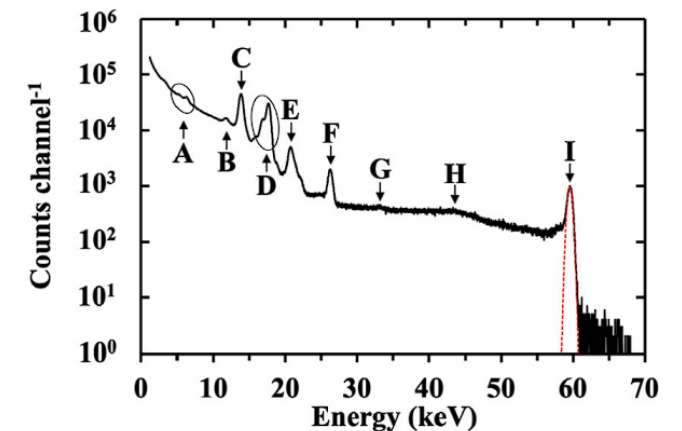
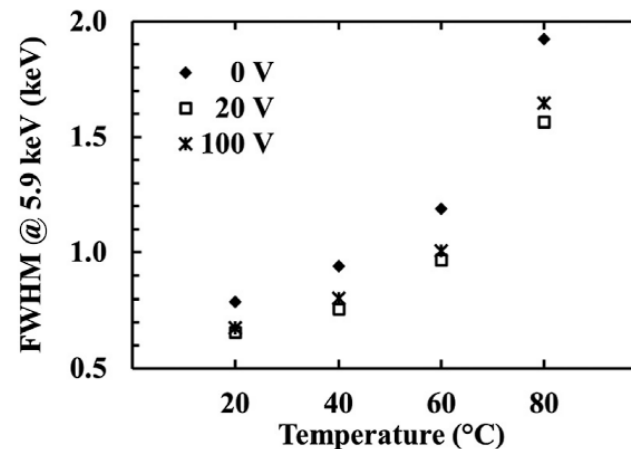
journal homepage: www.elsevier.com/locate/nima



Repurposing a low-cost commercial Si photodiode as a detector for X-ray and γ -ray spectroscopy at temperatures up to 80°C

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Space Research Group, School of Mathematical and Physical Sciences, University of Sussex, Falmer, Brighton, BN1 9QT, UK



241Am

Second option: Si-junction front-end electronics

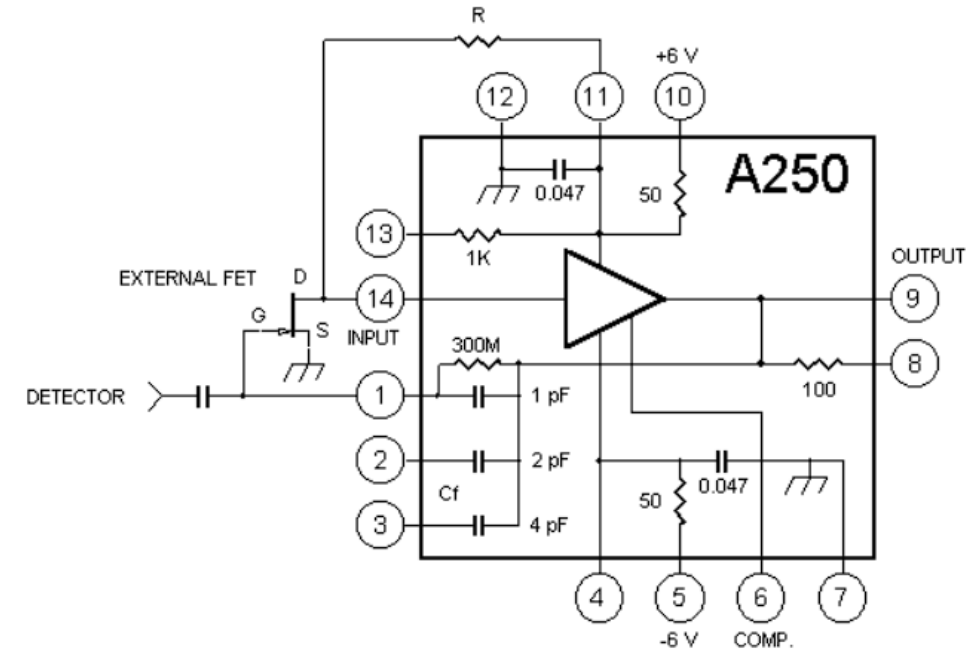


In-vacuum

Specifications		Assume temp =20 °C, $V_s = \pm 6V$, unloaded output	
	CR-110-R2.2	units	
Preamplification channels	1		
Equivalent noise charge (ENC)*			
ENC RMS	200	electrons	
	0.03	femtoCoul.	
Equivalent noise in silicon	1.7	keV (FWHM)	
Equivalent noise in CdZnTe	2.4	keV (FWHM)	
ENC slope	3.8	elect. RMS /pF	
Gain	1.4	volts /pC	
Rise time **	3	ns	
Decay time constant	140	μs	
Unsaturated output swing	-3 to +3	volts	
Maximum charge detectable per event	1.3×10^7	electrons	
	2.1	pC	
Power supply voltage (V_s)			
maximum	$V_s = \pm 13$	volts	
minimum	$V_s = \pm 6$	volts	
Power supply current (pos)	9	mA	
(neg)	6	mA	
Power dissipation with no load	85	mW	
Operating temperature	-40 to +85	$^{\circ}C$	
Output offset	+0.2 to -0.2	volts	
Output impedance	50	ohms	

Ready to use

A250 Connection Diagram amptek



New low noise scheme implemented by INFN-CT (FET close to the detector)

M. D'Andrea technical unit INFN-CT in charge